

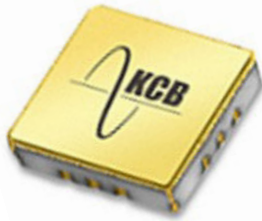
# KCB817

High Isolation SPST  
DC – 6 GHz



## DESCRIPTION

KCB817 is a GaAs pHEMT Non-Reflective high performance, low loss switch in a 3x3mm hermetic Surface-Mount Technology (SMT) package for Defense and Satellite application. This device can be supplied and tested to the screening requirements of MIL-PRF-38535 Class B and S, in addition to the required QCI.



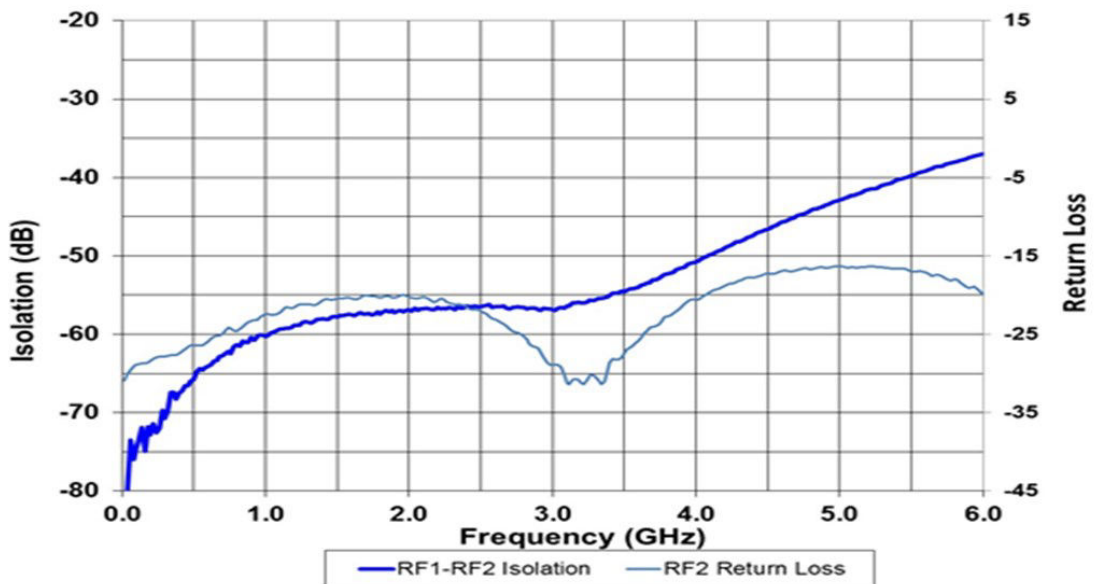
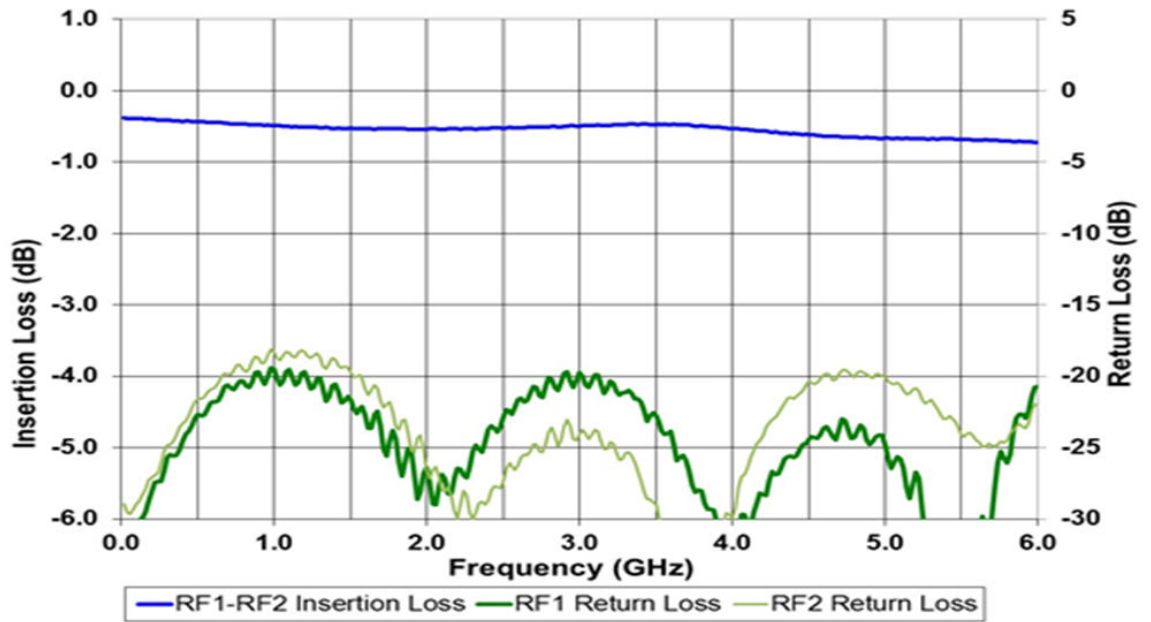
## FEATURES

- ✓ **Wideband frequency range: DC to 6 GHz**
- ✓ **Low Loss: 0.6 dB @ 2 GHz Isolation: 50 dB @ 2 GHz**
- ✓ **RF1 Reflective / RF2 Non Reflective**
- ✓ **NASA EEE-INST-002 Compliant**
- ✓ **Successfully Tested to 1M RAD TID**
- ✓ **High Reliability Class B and S Screening Available**
- ✓ **See Page 4 for MFR Hi -Rel Ordering Details**

## ELECTRICAL CHARACTERISTICS (+25°C)

Parameter	Conditions	Min	Typical	Max	Units
Insertion Loss	DC – 2.0 GHz		0.5	0.8	dB
	2.0 – 3.0 GHz		0.6	0.9	dB
	3.0 – 4.0 GHz		0.75	1.05	dB
	4.0 – 6.0 GHz		0.78	1.20	dB
RF1/RF2 Return Loss (ON-State)	DC – 2.0 GHz	20	25		dB
	2.0 – 3.0 GHz	20	25		dB
	3.0 – 4.0 GHz	18	22		dB
	4.0 – 6.0 GHz	15	18		dB
RF2 Return Loss (OFF-State)	DC – 2.0 GHz	18	20		dB
	2.0 – 3.0 GHz	18	20		dB
	3.0 – 4.0 GHz	18	20		dB
	4.0 – 6.0 GHz	15	20		dB
Isolation	DC – 2.0 GHz	50	57		dB
	2.0 – 3.0 GHz	45	55		dB
	3.0 – 4.0 GHz	38	45		dB
	4.0 – 6.0 GHz	27	35		dB
Input 1 dB Compression (P1dB)	Vctrl = 0V/-5V, 0.5- 2.0 GHz		+24		dBm
Third Order Output Intercept Point (IP3)	+13 dBm Input Tones, 1 MHz Spacing, Vctrl = 0V/5V, 0.5- 2.0 GHz		+46		dBm
Switching Speed: Rise, Fall ON/OFF	10/90% or 90/10% RF 50% CTL to 90/10% RF		5		nS
			15		nS
Vctrl High	DC Voltage	-4.5	-5.0	-7.0	V
Vctrl Low	DC Voltage	-0.2	0	+0.2	V
I ctrl	DC Current		50	200	uA

# TYPICAL PERFORMANCE (+25°C)

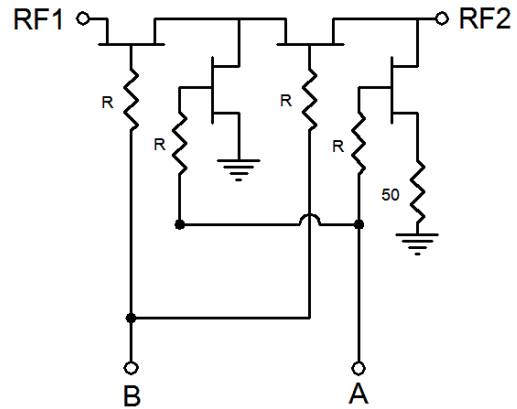


## TRUTH TABLE/CONTROL VOLTAGES

Control Input		Signal Path State
A	B	RF1 to RF2
High	Low	ON
Low	High	OFF

State	Bias Conditions
Low	0 @ 20 $\mu$ A
High	-5V @ 100 $\mu$ A

## SCHEMATIC

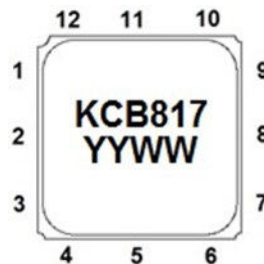


## ABSOLUTE MAXIMUM RATINGS

Exceeding Max limits may cause damage

Characteristic	Min.	Max.	Units
Control Voltage (A+B)	-7.5	+1.0	Volts
RF Input Power		+30	dBm
Storage Temperature	-65	+150	$^{\circ}$ C
Operating Case Temp	-55	+125	$^{\circ}$ C
Junction Temperature		+150	$^{\circ}$ C

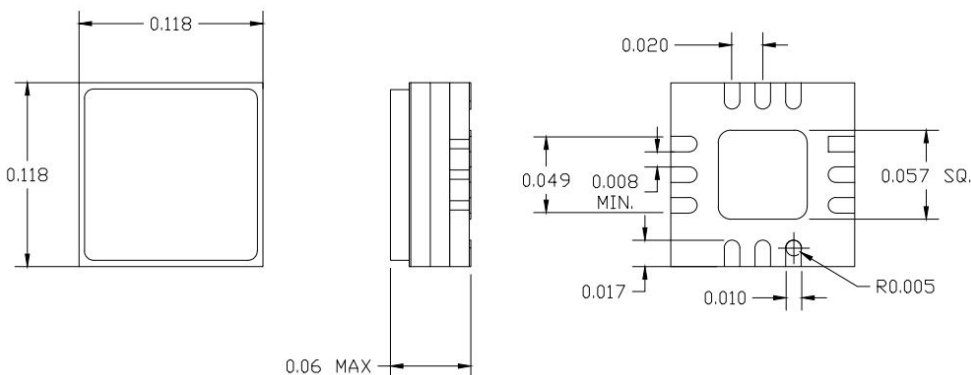
## PINOUT



XXX = Serial # will be added for Class B and S Part #

1	GND
2	RF1
3	GND
4	A
5	GND
6	B
7	GND
8	RF2
9	GND
10	GND
11	GND
12	GND

## OUTLINE DRAWING



Caution: Class 1A (HBM 250V) Electrostatic Sensitive Device. Proper ESD precaution should be used when handling device.

## MFR HI-REL SCREENING FLOW

Test Inspection	MIL – STD -883		Requirement	
	Method	Condition	Class B	Class S
Wafer Lot Acceptance /1	5007		N/A	Per Wafer Lot
Non-Destructive Bond Pull	2023		SPC	SPC
Internal Visual	2010	A= Class S, B = Class B	100%	100%
Temperature Cycle	1010	C	100%	100%
Acceleration	2001	E (Y1 only)	100%	100%
PIND	2020	A (5 Cycles)	N/A	100%
Serialization	Per Product Specification		100%	100%
Radiographic	2012	2 views	N/A	100%
Electrical Test	Small Signal Testing	+25°C	100%	100%
Burn In	1015	A	100%/160 Hours/125°C	100%/320 Hours/125 °C
Final Electrical	Small Signal Testing	+25°C	100%	100%
PDA Calculation	5004	25% Δ IL / 100% Δ Icc	5%	5%/3% functional
Group A Electrical /5	Per Product Specification	-55°C + 125°C	45/0	45/0
Leak Test	1014 A and C	1 x 10 <sup>-8</sup> Max	100%	100%
External Visual	2009		100%	100%

## NOTES

1. Product under configuration control per KCB QAP 015.
2. Customer will be notified of all class 1 changes for Class H and K part numbers.
3. Wafer Lot Acceptance will include 100% die visual, SEM analysis and Lot Traceability.
4. Electrical Test Data will be recorded for each serial number and included in Final Test Report for all Class S part numbers.
5. Group A Electrical testing will include the Small Signal and Ic at the Min/Max operating condition. The

## ORDERING INFORMATION

	Unscreened	Class B	Class S
KCB Solutions Part Number	KCB817C	KCB817B	KCB817S

